

Search Notes

Application/Control No.

10/511,262

Examiner

Edgardo San Martin

Applicant(s)/Patent under
Reexamination

LEE, JAY-MIN

Art Unit

2837

SEARCHED

Class	Subclass	Date	Examiner
181	176,175	12/7/2006	ESM
367	103,150		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference text search EAST; see printout		12/7/2006	ESM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text search EAST; see printout	12/7/2006	ESM